

STE250NS10

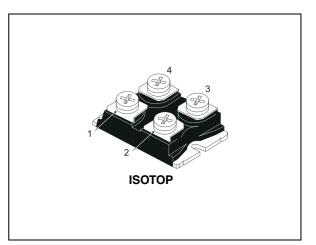
General features

Туре	V _{DSS}	R _{DS(on)}	۱ _D
STE250NS10	100V	<0.0055Ω	220A

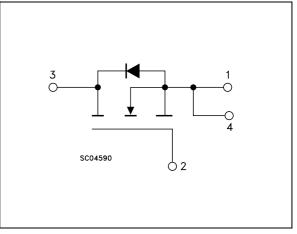
- Standard threshold drive
- 100% avalanche tested

Description

This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.



Internal schematic diagram



Applications

Switching application

Order codes

Part number Marking		Package	Packaging
STE250NS10	E250NS10	ISOTOP	Tube

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Electrical ratings

Table 1.	Absolute	maximum	ratings
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Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (v _{gs} = 0)	100	V
V _{GS}	Gate- source voltage	±20	V
I _D	Drain current (continuos) at $T_C = 25^{\circ}C$	220	Α
I _D	Drain current (continuos) at $T_C = 100^{\circ}C$	156	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	880	Α
P _{TOT}	Total dissipation at $T_C = 25^{\circ}C$	500	W
	Derating factor	4	W/°C
dv/dt ⁽²⁾	Peak diode recovery voltage slope	3.5	V/ns
V _{ISO}	Insulation winthstand voltage (DC)	2500	V
Т _Ј T _{stg}	Operating junction temperature Storage temperature	150 -55 to 150	°C

1. Pulse width limited by safe operating area

2. $I_{SD} \leq 220A$, di/dt $\leq 200A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_j \leq T_{JMAX}$

Table 2. Thermal data

R _{thj-case}	Thermal resistance junction-case Max	0.25	°CW
R _{thj-a}	Thermal resistance junction-ambient Max	50	°CW

Table 3. Avalanche characteristics

Symbol Parameter		Value	Unit
I _{AS}	Avalanche current, repetitive or not-repetitive (pulse width limited by Tj Max)	220	A
E _{AS}	Single pulse avalanche energy (starting Tj=25°C, Id=lar, Vdd=64V)	800	mJ

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown voltage	I _D = 1 mA, V _{GS} = 0	100			V
	Zero gate voltage	V _{DS} = Max rating			50	μA
I _{DSS}	Drain current ($V_{GS} = 0$)	V _{DS} = Max rating, T _C =125°C			500	μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20V$			±400	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 125A		0.0045	0.0055	Ω

Table 4. On/off states

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs}	Forward transconductance	V _{DS} = 20V _, I _D =70A		60		S
C _{iss}	Input capacitance			31		nF
C _{oss}	Output capacitance	V _{DS} = 25V, f = 1 MHz, V _{GS} = 0		4.3		nF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$		1.2		nF
Qg	Total gate charge			900		nC
Q _{gs}	Gate-source charge	$V_{DD} = 50V$, $I_D = 22A$, $V_{GS} = 10V$		160		nC
Q _{gd}	Gate-drain charge	VGS - 10V		330		nC

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	V_{DD} =50 V, I _D =125A, R _G =4.7 Ω , V _{GS} = 10V (see Figure 13)		110 380		ns ns
t _{d(off)} t _f	Turn-off-delay time Fall time	V_{DD} =50 V, I _D =125A, R _G =4.7 Ω , V _{GS} = 10V (see Figure 13)		1100 300		ns ns
t _{r(Voff)} t _f t _c	Off-voltage rise time fall time cross-over time	V_{DD} =80V, I _D =220A, R _G =4.7 Ω , V _{GS} =10V (see Figure 15)		950 330 600		ns ns ns

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				220	Α
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				880	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 220A, V_{GS} = 0$			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 220A, V_{DD} = 30V$ di/dt = 100A/µs, $T_j = 150^{\circ}C$ (see Figure 15)		200 1.35 13.5		ns μC Α

Table 7. Source drain diode

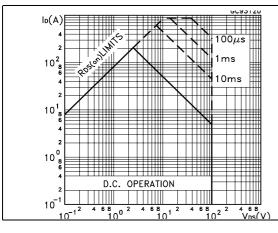
1. Pulse width limited by safe operating area.

2. Pulsed: Pulse duration = 300 $\mu s,$ duty cycle 1.5 %



2.1 Electrical characteristics (curves)

Figure 1. Safe operating area





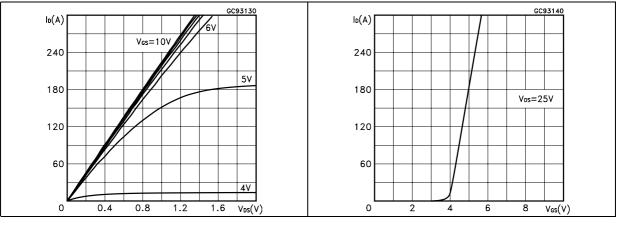
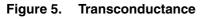
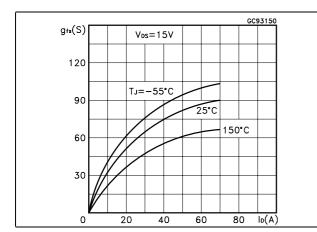
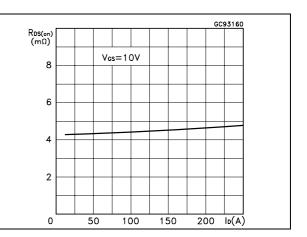


Figure 2.



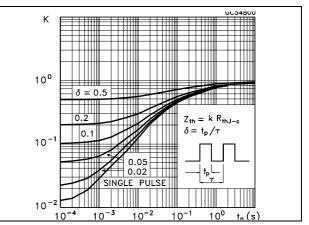












Thermal impedance

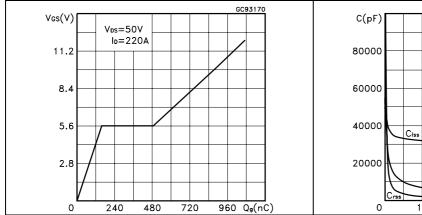
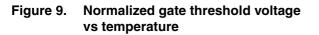


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations



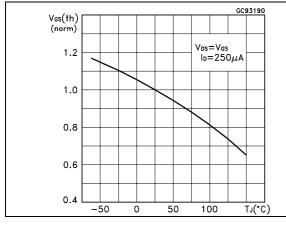


Figure 11. Source-drain diode forward characteristics

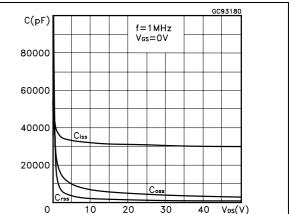


Figure 10. Normalized on resistance vs temperature

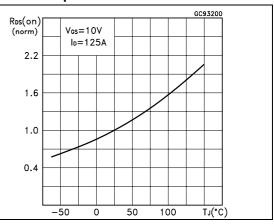
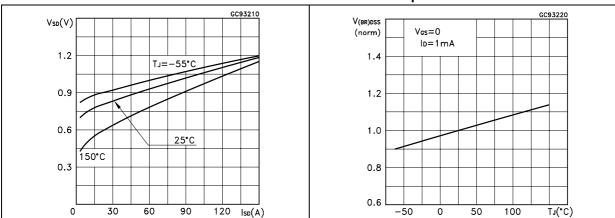
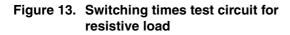


Figure 12. Normalized breakdown voltage vs temperature



3 Test circuit



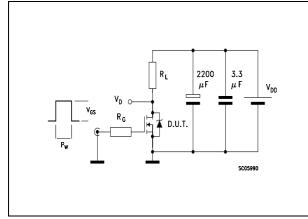
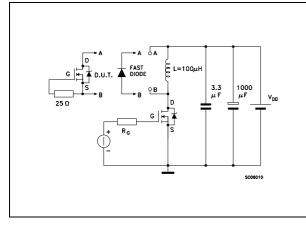
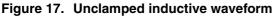
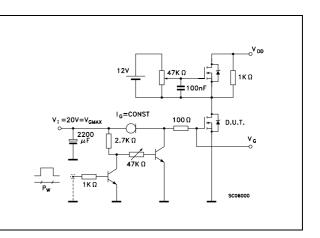
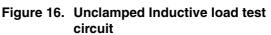


Figure 15. Test circuit for inductive load switching and diode recovery times









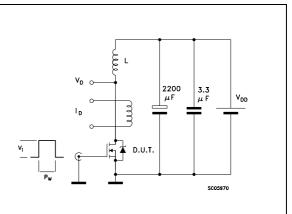
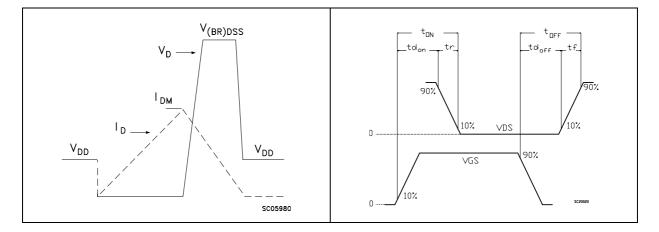


Figure 18. Switching time waveform



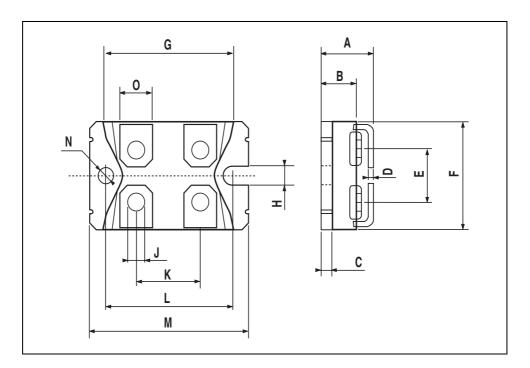
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at : *www.st.com*



DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	11.8		12.2	0.466		0.480
В	8.9		9.1	0.350		0.358
С	1.95		2.05	0.076		0.080
D	0.75		0.85	0.029		0.033
E	12.6		12.8	0.496		0.503
F	25.15		25.5	0.990		1.003
G	31.5		31.7	1.240		1.248
н	4			0.157		
J	4.1		4.3	0.161		0.169
к	14.9		15.1	0.586		0.594
L	30.1		30.3	1.185		1.193
М	37.8		38.2	1.488		1.503
Ν	4			0.157		
0	7.8		8.2	0.307		0.322

ISOTOP MECHANICAL DATA



5 Revision history

Table 8.	Revision	history
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Date	Revision	Changes	
21-Jun-2004	1	Complete version	
04-Oct-2006	2	New template, no content change	



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